

<b>Notice of References Cited</b>	Application/Control No. 10/663,382		Applicant(s)/Patent Under Reexamination BERINGER ET AL.	
	Examiner Van Kim T. Nguyen		Art Unit 2152	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,643,661	11-2003	Polizzi et al.	707/100
*	C	US-6,668,353	12-2003	Yurkovic, Robert J.	715/205
*	D	US-2004/0098467	05-2004	Dewey et al.	709/219
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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